

LF7134-F - April 5, 2022

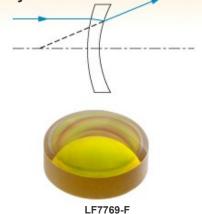
Item # LF7134-F was discontinued on April 4, 2022. For informational purposes, this is a copy of the website content at that time and is valid only for the stated product.

ZINC SELENIDE NEGATIVE MENISCUS LENSES, AR COATED: 8 - 12 MM

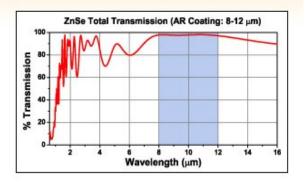
- AR Coating Optimized for the 8 12 µm Range
- ► Ideal for CO₂ Laser Applications Due to Low Absorption Coefficient

Decreases the NA of an Optical System





(Ø1/2")



OVERVIEW

Features

- ZnSe Substrate
- $\bullet~$ Broadband AR Coating for the 8 12 μm Range
- Focal Lengths from -15 mm to -1000 mm Available

Thorlabs' Ø1/2" and Ø1" Zinc Selenide (ZnSe) Negative Meniscus Lenses are available with a broadband AR coating optimized for the 8 μm to 12 μm spectral range deposited on both surfaces. This coating greatly reduces the high surface reflectivity of the substrate, yielding an average transmission in excess of 97% over the entire AR coating range. See the *Graphs* tab for detailed information.

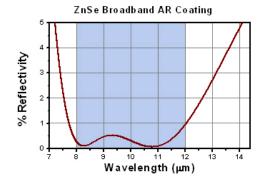
Negative meniscus (convex-concave) lenses, which are thinner in the middle than at the edges and cause light rays to diverge, are designed to minimize third-order spherical aberration. When used to diverge light, the convex surface should face the beam to minimize spherical aberration. They are often used in conjunction with other lenses to increase the focal length, and therefore decrease the numerical aperture (NA), of an optical assembly. ZnSe lenses are particularly well suited for use with high-power CO₂ lasers.

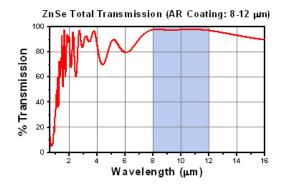
When handling optics, one should always wear gloves. This is especially

Spec	cifications
Substrate Material	Laser-Grade Zinc Selenide ^a
AR Coating Range	8 - 12 μm
Reflectance over Coating Range (Avg.)	<1.5%
Damage Threshold ^b	5 J/cm ² (10.6 μm, 100 ns, 1 Hz, Ø0.478 mm)
Diameter Tolerance	+0.00/-0.10
Thickness Tolerance	±0.2 mm
Focal Length Tolerance	±1%
Surface Quality	60-40 Scratch-Dig
Spherical Surface Power ^c	3λ/2
Spherical Surface Irregularity (Peak to Valley)	λ/2
Centration	≤3 arcmin
Clear Aperture	80% of Diameter
Design Wavelength	10.6 μm



GRAPHS





Shown above is a graph of the theoretical percent reflectivity of the AR coating as a function of wavelength. The average reflectivity in the 8 - 12 µm range is <1.5%. The blue shading indicates the region for which the AR coating is optimized.

Shown above is a graph of the theoretical transmission of the AR-coated zinc selenide Bi-Convex lens. The blue shaded region denotes the 8 - 12 μ m spectral range where the AR coating is optimized. For this wavelength range, the measured transmission is in excess of 97%.

Total Transmission of Optic (ZnSe Substrate + AR Coating)

The table below gives the approximate transmission of these optics for a few select wavelengths in the 0.6 - 16 µm range. To see an excel file that lists all measured transmission values for this wavelength range, please click here. Please note that the transmission values stated for wavelengths outside of the AR coating range are approximate and can vary significantly by coating lot.

Wavelength (μm)	Total Transmission	Wavelength (µm)	Total Transmission	Wavelength (µm)	Total Transmission	Wavelength (µm)	Total Transmission
0.6	0.117	4.6	0.740	8.6	0.978	12.6	0.961
1.0	0.312	5.0	0.880	9.0	0.975	13.0	0.953
1.4	0.674	5.4	0.874	9.4	0.975	13.4	0.945
1.8	0.875	5.8	0.810	9.8	0.976	13.8	0.936
2.2	0.810	6.2	0.802	10.2	0.978	14.2	0.928
2.6	0.803	6.6	0.845	10.6	0.979	14.6	0.920
3.0	0.859	7.0	0.904	11.0	0.979	15.0	0.913
3.4	0.880	7.4	0.950	11.4	0.977	15.4	0.906
3.8	0.962	7.8	0.973	11.8	0.973	15.8	0.900
4.2	0.733	8.2	0.979	12.2	0.968		

Damage Threshold Data for Thorlabs' F-Coated ZnSe Lenses

The specifications to the right are measured data for Thorlabs' F-coated, ZnSe lenses. Damage threshold specifications are constant for all F-coated, ZnSe lenses, regardless of the size or focal length of the lens.

Damage Threshold Spec	ifications
Coating Designation (Item # Suffix)	Damage Threshold
-F	5 J/cm ² (10.6 μm, 100 ns, 1 Hz, Ø0.478 mm)

Laser Induced Damage Threshold Tutorial

The following is a general overview of how laser induced damage thresholds are measured and how the values may be utilized in determining the appropriateness of an optic for a given application. When choosing optics, it is important to understand the Laser Induced Damage Threshold (LIDT) of the optics being used. The LIDT for an optic greatly depends on the type of laser you are using. Continuous wave (CW) lasers typically cause damage from thermal effects (absorption either in the coating or in the substrate). Pulsed lasers, on the other hand, often strip electrons from the lattice structure of an optic before causing thermal damage. Note that the guideline presented here assumes room temperature operation and optics in new condition (i.e., within scratch-dig spec, surface free of contamination, etc.). Because dust or other particles on the surface of an optic can cause damage at lower thresholds, we recommend keeping surfaces clean and free of debris. For more information on cleaning optics, please see our *Optics Cleaning* tutorial.

Testing Method

Thorlabs' LIDT testing is done in compliance with ISO/DIS 11254 and ISO 21254 specifications.

First, a low-power/energy beam is directed to the optic under test. The optic is exposed in 10 locations to this laser beam for 30 seconds (CW) or for a number of pulses (pulse repetition frequency specified). After exposure, the optic is examined by a microscope (~100X magnification) for any visible damage. The number of locations that are damaged at a particular power/energy level is recorded. Next, the power/energy is either increased or decreased and the optic is exposed at 10 new locations. This process is repeated until damage is observed. The damage threshold is then assigned to be the highest power/energy that the optic can withstand without causing damage. A histogram such as that below represents the testing of one BB1-E02 mirror.

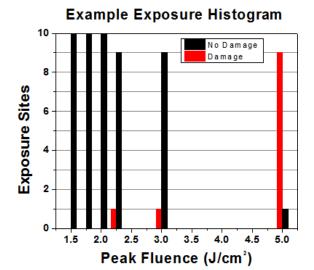


The photograph above is a protected aluminumcoated mirror after LIDT testing. In this particular test, it handled 0.43 J/cm^2 (1064 nm, 10 ns pulse, 10 Hz, Ø1.000 mm) before damage.

According to the test, the damage threshold of the mirror was 2.00 J/cm^2 (532 nm, 10 ns pulse, 10 Hz, $\emptyset 0.803 \text{ mm}$). Please keep in mind that these tests are performed on clean optics, as dirt and contamination can significantly lower the damage threshold of a component. While the test results are only representative of one coating run, Thorlabs specifies damage threshold values that account for coating variances.

Continuous Wave and Long-Pulse Lasers

When an optic is damaged by a continuous wave (CW) laser, it is usually due to the melting of the surface as a result of absorbing the laser's energy or damage to



	Example Test Data									
Fluence	# of Tested Locations	Locations with Damage	Locations Without Damage							
1.50 J/cm ²	10	0	10							
1.75 J/cm ²	10	0	10							
2.00 J/cm ²	10	0	10							
2.25 J/cm ²	10	1	9							
3.00 J/cm ²	10	1	9							
5.00 J/cm ²	10	9	1							

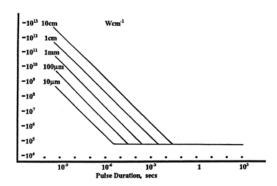
the optical coating (antireflection) [1]. Pulsed lasers with pulse lengths longer than 1 µs can be treated as CW lasers for LIDT discussions.

When pulse lengths are between 1 ns and 1 µs, laser-induced damage can occur either because of absorption or a dielectric breakdown (therefore, a user must check both CW and pulsed LIDT). Absorption is either due to an intrinsic property of the optic or due to surface irregularities; thus LIDT values are only valid for optics meeting or exceeding the surface quality specifications given by a manufacturer. While many optics can handle high power CW lasers, cemented (e.g., achromatic doublets) or highly absorptive (e.g., ND filters) optics tend to have lower CW damage thresholds. These lower thresholds are due to absorption or scattering in the cement or metal coating.

Pulsed lasers with high pulse repetition frequencies (PRF) may behave similarly to CW beams. Unfortunately, this is highly dependent on factors such as absorption and thermal diffusivity, so there is no reliable method for determining when a high PRF laser will damage an optic due to thermal effects. For beams with a high PRF both the average and peak powers must be compared to the equivalent CW power. Additionally, for highly transparent materials, there is little to no drop in the LIDT with increasing PRF.

In order to use the specified CW damage threshold of an optic, it is necessary to know the following:

- 1. Wavelength of your laser
- 2. Beam diameter of your beam (1/e2)
- 3. Approximate intensity profile of your beam (e.g., Gaussian)
- Linear power density of your beam (total power divided by 1/e² beam diameter)

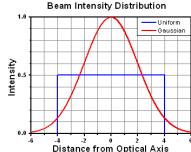


LIDT in linear power density vs. pulse length and spot size. For long pulses to CW, linear power density becomes a constant with spot size. This graph was obtained from [1].

Thorlabs expresses LIDT for CW lasers as a linear power density measured in W/cm. In this regime, the LIDT given as a linear power density can be applied to any beam diameter; one does not need to compute an adjusted LIDT to adjust for changes in spot size, as demonstrated by the graph to the right. Average linear power density can be calculated using the equation below.

$$Linear Power Density = \frac{Power}{Beam Diameter}$$

The calculation above assumes a uniform beam intensity profile. You must now consider hotspots Distance from Opin the beam or other non-uniform intensity profiles and roughly calculate a maximum power density. For reference, a Gaussian beam typically has a maximum power density that is twice that of the uniform beam (see lower right).



Now compare the maximum power density to that which is specified as the LIDT for the optic. If the optic was tested at a wavelength other than your operating wavelength, the damage threshold must be scaled appropriately. A good rule of thumb is that the damage threshold has a linear relationship with wavelength such that as you move to shorter wavelengths, the damage threshold decreases (i.e., a LIDT of 10 W/cm at 1310 nm scales to 5 W/cm at 655 nm):

$$Adjusted\ LIDT = LIDT\ Power\left(\frac{Your\ Wavelength}{LIDT\ Wavelength}\right)$$

While this rule of thumb provides a general trend, it is not a quantitative analysis of LIDT vs wavelength. In CW applications, for instance, damage scales more strongly with absorption in the coating and substrate, which does not necessarily scale well with wavelength. While the above procedure provides a good rule of thumb for LIDT values, please contact Tech Support if your wavelength is different from the specified LIDT wavelength. If your power density is less than the adjusted LIDT of the optic, then the optic should work for your application.

Please note that we have a buffer built in between the specified damage thresholds online and the tests which we have done, which accommodates variation between batches. Upon request, we can provide individual test information and a testing certificate. The damage analysis will be carried out on a similar optic (customer's optic will not be damaged). Testing may result in additional costs or lead times. Contact Tech Support for more information.

Pulsed Lasers

As previously stated, pulsed lasers typically induce a different type of damage to the optic than CW lasers. Pulsed lasers often do not heat the optic enough to damage it; instead, pulsed lasers produce strong electric fields capable of inducing dielectric breakdown in the material. Unfortunately, it can be very difficult to compare the LIDT specification of an optic to your laser. There are multiple regimes in which a pulsed laser can damage an optic and this is based on the laser's pulse length. The highlighted columns in the table below outline the relevant pulse lengths for our specified LIDT values.

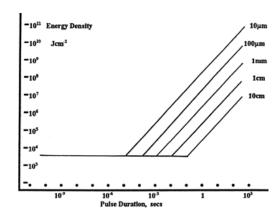
Pulses shorter than 10⁻⁹ s cannot be compared to our specified LIDT values with much reliability. In this ultra-short-pulse regime various mechanics, such as multiphoton-avalanche ionization, take over as the predominate damage mechanism [2]. In contrast, pulses between 10⁻⁷ s and 10⁻⁴ s may cause damage to an optic either because of dielectric breakdown or thermal effects. This means that both CW and pulsed damage thresholds must be compared to the laser beam to determine whether the optic is suitable for your application.

Pulse Duration	t < 10 ⁻⁹ s	10 ⁻⁹ < t < 10 ⁻⁷ s	10 ⁻⁷ < t < 10 ⁻⁴ s	t > 10 ⁻⁴ s
Damage Mechanism	Avalanche Ionization	Dielectric Breakdown	Dielectric Breakdown or Thermal	Thermal
Relevant Damage Specification	No Comparison (See Above)	Pulsed	Pulsed and CW	cw

When comparing an LIDT specified for a pulsed laser to your laser, it is essential to know the following:

- 1. Wavelength of your laser
- 2. Energy density of your beam (total energy divided by 1/e² area)
- 3. Pulse length of your laser
- 4. Pulse repetition frequency (prf) of your laser
- 5. Beam diameter of your laser (1/e2)
- 6. Approximate intensity profile of your beam (e.g., Gaussian)

The energy density of your beam should be calculated in terms of J/cm^2 . The graph to the right shows why expressing the LIDT as an energy density provides the best metric for short pulse sources. In this regime, the LIDT given as an energy density can be applied to any beam diameter; one does not need to compute an adjusted LIDT to adjust for changes in spot size. This calculation assumes a uniform beam intensity profile. You must now adjust this energy density to account for hotspots or other nonuniform intensity profiles and roughly calculate a maximum energy density. For reference a Gaussian beam typically has a maximum energy density that is twice that of the $1/e^2$ beam.



LIDT in energy density vs. pulse length and spot size. For short pulses, energy density becomes a constant with spot size. This graph was obtained from [1].

Now compare the maximum energy density to that which is specified as the LIDT for the optic. If the optic was tested at a wavelength other than your operating wavelength,

the damage threshold must be scaled appropriately [3]. A good rule of thumb is that the damage threshold has an inverse square root relationship with wavelength such that as you move to shorter wavelengths, the damage threshold decreases (i.e., a LIDT of 1 J/cm² at 1064 nm scales to 0.7 J/cm² at 532 nm):

$$Adjusted\ LIDT = LIDT\ Energy \sqrt{\frac{Your\ Wavelength}{LIDT\ Wavelength}}$$

You now have a wavelength-adjusted energy density, which you will use in the following step.

Beam diameter is also important to know when comparing damage thresholds. While the LIDT, when expressed in units of J/cm², scales independently of spot size; large beam sizes are more likely to illuminate a larger number of defects which can lead to greater variances in the LIDT [4]. For data presented here, a <1 mm beam size was used to measure the LIDT. For beams sizes greater than 5 mm, the LIDT (J/cm2) will not scale independently of beam diameter due to the larger size beam exposing more defects.

The pulse length must now be compensated for. The longer the pulse duration, the more energy the optic can handle. For pulse widths between 1 - 100 ns, an approximation is as follows:

$$Adjusted \ LIDT = LIDT \ Energy \sqrt{\frac{Your \ Pulse \ Length}{LIDT \ Pulse \ Length}}$$

Use this formula to calculate the Adjusted LIDT for an optic based on your pulse length. If your maximum energy density is less than this adjusted LIDT maximum energy density, then the optic should be suitable for your application. Keep in mind that this calculation is only used for pulses between 10⁻⁹ s and 10⁻⁷ s. For pulses between 10⁻⁷ s and 10⁻⁴ s, the CW LIDT must also be checked before deeming the optic appropriate for your application.

Please note that we have a buffer built in between the specified damage thresholds online and the tests which we have done, which accommodates variation

between batches. Upon request, we can provide individual test information and a testing certificate. Contact Tech Support for more information.

- [1] R. M. Wood, Optics and Laser Tech. 29, 517 (1998).
- [2] Roger M. Wood, Laser-Induced Damage of Optical Materials (Institute of Physics Publishing, Philadelphia, PA, 2003).
- [3] C. W. Carr et al., Phys. Rev. Lett. 91, 127402 (2003).
- [4] N. Bloembergen, Appl. Opt. **12**, 661 (1973).

MOUNTING OPTIONS



Click to Enlarge LMR1 Fixed Mount with Ø1" Lens



Click to Enlarge CXY1 Translation Mount and SM1 Lens Tube Mounted in a 30 mm Cage System



Click to Enlarge LM2XY Translating Mount with Ø2" Lens



Click to Enlarge Ø1" Optic Mounted in a ST1XY-S XY Translator

		Recommended Mounting Options for Thorlabs Lenses			
Ite	m #	Mounto for 62 mm to 640 mm Ontico			
Imperial	Metric	Mounts for Ø2 mm to Ø10 mm Optics			
(Var	ious)	Fixed Lens Mounts and Mini-Series Fixed Lens Mounts for Small Optics, Ø5 mm to Ø10 mm			
(Var	ious)	Small Optic Adapters for Use with Standard Fixed Lens Mounts, Ø2 mm to Ø10 mm			
Ite	m #	Mounto for (X4/2" (X42.7 mm) Ontice			
Imperial	Metric	Mounts for Ø1/2" (Ø12.7 mm) Optics			
LMR05 LMR05/M		Fixed Lens Mount for Ø1/2" Optics			
MLH05	MLH05/M	Mini-Series Fixed Lens Mount for Ø1/2" Optics			
LM05XY	LM05XY/M	Translating Lens Mount for Ø1/2" Optics			
SC	P05	16 mm Cage System, XY Translation Mount for Ø1/2" Optics			
(Var	ious)	Ø1/2" Lens Tubes, Optional SM05RRC Retaining Ring for High-Curvature Lenses (See Below)			
Ite	m #	Mounts for Ø1" (Ø25.4 mm) Optics			
Imperial	Metric	mounts for \$1 (\$225.4 filling) Optics			
LMR1	LMR1/M	Fixed Lens Mount for Ø1" Optics			
LM1XY	LM1XY/M	Translating Lens Mount for Ø1" Optics			

ST1XY-S ST1XY-S/M		Translating Lens Mount with Micrometer Drives (Other Drives Available)			
CX	Y1	30 mm Cage System, XY Translation Mount for Ø1" Optics			
(Various)		Ø1" Lens Tubes, Optional SM1RRC Retaining Ring for High-Curvature Lenses (See Below)			
Iter	n #	Mount for Ø1.5" Optics			
Imperial	Metric	Mount for 9 1.9 Optics			
LMR1.5	LMR1.5/M	Fixed Lens Mount for Ø1.5" Optics			
(Vari	ous)	Ø1.5" Lens Tubes, Optional SM1.5RR Retaining Ring for Ø1.5" Lens Tubes and Mounts			
Iter	n #	Manufa for GOU (GEO O man) Ontice			
Imperial Metric		Mounts for Ø2" (Ø50.8 mm) Optics			
LMR2	LMR2/M	Fixed Lens Mount for Ø2" Optics			
LM2XY LM2XY/M		Translating Lens Mount for Ø2" Optics			
CX	Y2	60 mm Cage System, XY Translation Mount for Ø2" Optics			
(Vari	ous)	Ø2" Lens Tubes, Optional SM2RRC Retaining Ring for High-Curvature Lenses (See Below)			
Iter	n #				
Imperial	Metric	Adjustable Optic Mounts			
LH1	LH1/M	Adjustable Mount for Ø0.28" (Ø7.1 mm) to Ø1.80" (Ø45.7 mm) Optics			
LH2	LH2/M	Adjustable Mount for Ø0.77" (Ø19.6 mm) to Ø2.28" (Ø57.9 mm) Optics			
VG100	VG100/M	Adjustable Clamp for Ø0.5" (Ø13 mm) to Ø3.5" (Ø89 mm) Optics			
SCL03	SCL03/M	Self-Centering Mount for Ø0.15" (Ø3.8 mm) to Ø1.77" (Ø45.0 mm) Optics			
SCL04	SCL04/M	Self-Centering Mount for Ø0.15" (Ø3.8 mm) to Ø3.00" (Ø76.2 mm) Optics			
LH160C LH160C/M		Adjustable Mount for 60 mm Cage Systems, Ø0.50" (Ø13 mm) to Ø2.00" (Ø50.8 mm) Optics			
SCL60C SCL60C/M		Self-Centering Mount for 60 mm Cage Systems, Ø0.15" (Ø3.8 mm) to Ø1.77" (Ø45.0 mm) Optics			

Ø1/2" Negative Meniscus Lenses

Item #	Diameter	Focal Length	Diopter ^a	Radius of Curvature 1	Radius of Curvature 2	Center Thickness	Edge Thickness ^b	Back Focal Length ^c	Reference Drawing
LF7769-F	1/2"	-15.0 mm	-66.6	13.5 mm	7.5 mm	2.0 mm	3.9 mm	-13.7 mm	
LF7134-F	1/2"	-20.0 mm	-50.0	12.6 mm	7.9 mm	2.0 mm	3.5 mm	-18.2 mm	0
LF7185-F	1/2"	-40.0 mm	-25.0	10.9 mm	7.6 mm	3.0 mm	4.3 mm	-33.6 mm	

Suggested Fixed Lens Mounts: LMR05(/M)

- Reciprocal of the Focal Length in Meters
- Edge Thickness Given Before 0.2 mm at 45° Typical Chamfer
- Measured at the Design Wavelength, 10.6 μm



These items will be retired without replacement when stock is depleted. If you require these parts for line production, please contact our OEM Team.

Part Number	Description	Price	Availability
LF7769-F	Ø1/2" ZnSe Negative Meniscus Lens, f = -15.0 mm, ARC: 8-12 μm	\$395.97	Lead Time
LF7134-F	Ø1/2" ZnSe Negative Meniscus Lens, f = -20.0 mm, ARC: 8-12 μm	\$395.97	Lead Time
LF7185-F	Ø1/2" ZnSe Negative Meniscus Lens, f = -40.0 mm, ARC: 8-12 μm	\$395.97	Today

Ø1" Negative Meniscus Lenses

Item #	Diameter	Focal Length	Diopter ^a	Radius of Curvature 1	Radius of Curvature 2	Center Thickness	Edge Thickness ^b	Back Focal Length ^c	Reference Drawing
LF7733-F ^d	1"	-25.4 mm	-39.4	31.6 mm	15.5 mm	4.0 mm	8.0 mm	-23.5 mm	
LF7601-F ^e	1"	-50.0 mm	-20.0	23.0 mm	15.6 mm	4.0 mm	6.7 mm	-44.9 mm	
LF7053-Fe	1"	-75.0 mm	-13.3	21.0 mm	15.5 mm	4.0 mm	6.3 mm	-66.6 mm	
LF7321-F ^e	1"	-200.0 mm	-5.0	57.7 mm	45.9 mm	4.0 mm	4.4 mm	-191.9 mm	0
LF7639-F ^e	1"	-500.0 mm	-2.0	146.1 mm	119.0 mm	4.0 mm	4.1 mm	-492.0 mm	
LF7589-F ^e	1"	-750.0 mm	-1.3	219.6 mm	179.7 mm	4.0 mm	4.1 mm	-742.0 mm	
LF7573-F ^e	1"	-1000.0 mm	-1.0	293.0 mm	240.5 mm	4.0 mm	4.1 mm	-992.0 mm	

Limited

These items will be retired without replacement when stock is depleted. If you require these parts for line production, please contact our OEM Team.

- Reciprocal of the Focal Length in Meters
- Edge Thickness Given Before 0.2 mm at 45° Typical Chamfer
- $\bullet~$ Measured at the Design Wavelength, 10.6 μm
- Suggested Fixed Lens Mounts: LMR1(/M) & SM1L05
- Suggested Fixed Lens Mount: LMR1(/M)

Part Number	Description	Price	Availability
LF7733-F	Ø1" ZnSe Negative Meniscus Lens, f = -25.4 mm, ARC: 8-12 μm	\$572.33	Lead Time
LF7601-F	Ø1" ZnSe Negative Meniscus Lens, f = -50.0 mm, ARC: 8-12 µm	\$572.33	Today
LF7053-F	Ø1" ZnSe Negative Meniscus Lens, f = -75.0 mm, ARC: 8-12 μm	\$572.33	Today
LF7321-F	Ø1" ZnSe Negative Meniscus Lens, f = -200.0 mm, ARC: 8-12 µm	\$572.33	Today
LF7639-F	Ø1" ZnSe Negative Meniscus Lens, f = -500.0 mm, ARC: 8-12 µm	\$572.33	Today
LF7589-F	Ø1"" ZnSe Negative Meniscus Lens, f = -750.0 mm, ARC: 8-12 μm	\$572.33	Today
LF7573-F	Ø1" ZnSe Negative Meniscus Lens, f = -1000.0 mm, ARC: 8-12 μm	\$572.33	Today